

Notice of References Cited	Application/Control No. 10/659,491	Applicant(s)/Patent Under Reexamination DEWEY ET AL.	
	Examiner Anh T.N. Vo	Art Unit 2861	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,250,957	10-1993	Onozato, Takashi	347/7
*	B	US-5,980,032	11-1999	Pawlowski et al.	347/86
*	C	US-6,364,458	04-2002	Eckard et al.	347/49
*	D	US-6,481,829	11-2002	Bailey et al.	347/49
*	E	US-6,550,894	04-2003	Ueno et al.	347/49
*	F	US-2002/0118262	08-2002	Seino et al.	347/86
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.